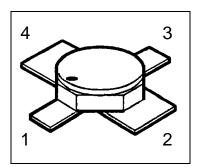


# HiRel NPN Silicon RF Transistor

- HiRel Discrete and Microwave Semiconductor
- For low noise, high-gain amplifiers up to 2GHz.
- For linear broadband amplifiers
- Hermetically sealed microwave package
- f<sub>T</sub>= 6,5 GHz
  F = 3 dB at 2 GHz
- CC CSA Space Qualified ESA/SCC Detail Spec. No.: 5611/006 Type Variant No. 07

**ESD**: Electrostatic discharge sensitive device, observe handling precautions!



Туре	Marking	Ordering Code	Pin Configuration		Package		
BFY196 (ql)	-	see below	С	Е	В	Е	Micro-X1

- (ql) Quality Level: P: Professional Quality
  - H: High Rel Quality
  - S: Space Quality

ES: ESA Space Quality

(see order instructions for ordering example)



### **Maximum Ratings**

Parameter	Symbol	Values	Unit	
Collector-emitter voltage	V <sub>CEO</sub>	12	V	
Collector-emitter voltage, $V_{BE}=0$	V <sub>CES</sub>	20	V	
Collector-base voltage	V <sub>CBO</sub>	20	V	
Emitter-base voltage	V <sub>EBO</sub>	2	V	
Collector current	Ι <sub>c</sub>	100	mA	
Base current	I <sub>B</sub>	12 <sup>1)</sup>	mA	
Total power dissipation, $T_S \leq 105^{\circ}C^{-2), 3}$	P <sub>tot</sub>	700	mW	
Junction temperature	Tj	200	°C	
Operating temperature range	T <sub>op</sub>	-65+200	°C	
Storage temperature range	T <sub>stg</sub>	-65+200	°C	

#### **Thermal Resistance**

Junction-soldering point <sup>3.)</sup>	R <sub>th JS</sub>	< 135	K/W
NL 4 4 4			

### Notes .:

1) The maximum permissible base current for V<sub>FBE</sub> measurements is 50mA (spot-

measurement duration < 1s)

2) At  $T_s = +105$  °C. For  $T_s > +105$  °C derating is required. 3)  $T_s$  is measured on the collector lead at the soldering point to the pcb.

## **Electrical Characteristics**

at T<sub>A</sub>=25°C; unless otherwise specified

Parameter	Symbol	Values		Unit	
		min.	typ.	max.	

### **DC Characteristics**

Do onaraoteristios					
Collector-base cutoff current	I <sub>CBO</sub>	-	-	100	μA
$V_{CB} = 20 \text{ V}, I_{E} = 0$					
Collector-emitter cutoff current	I <sub>CEX</sub>	-	-	1000	μA
$V_{CE} = 12 \text{ V}, I_B = 1 \mu \text{A}^{-1.3}$					
Collector-base cutoff current	I <sub>CBO</sub>	-	-	50	nA
$V_{CB} = 10 \text{ V}, I_E = 0$					
Emitter base cuttoff current	I <sub>EBO</sub>	-	-	25	μA
$V_{EB} = 2 V, I_{C} = 0$					
Emitter base cuttoff current	I <sub>EBO</sub>	-	-	0.5	μA
$V_{EB} = 1 \ V, \ I_{C} = 0$					

### Notes:

1.) This Test assures V(BR)CE0 > 12V IFAG IMM RPD D HIR



# Electrical Characteristics (continued)

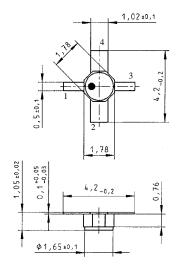
Parameter	Symbol		Values	5	Unit
		min.	typ.	max.	
DC Characteristics			·		
Base-Emitter forward voltage	V <sub>FBE</sub>	-	-	1	V
$I_{E} = 50 \text{ mA}, I_{C} = 0$					
DC current gain	h <sub>FE</sub>	50	100	175	-
$I_{C} = 50 \text{ mA}, V_{CE} = 8 \text{ V}$					
AC Characteristics					
Transition frequency	f <sub>T</sub>	6	6.5	-	GHz
$I_{\text{C}}$ = 70 mA, $V_{\text{CE}}$ = 5 V, f = 500 MHz					
Collector-base capacitance	C <sub>CB</sub>	-	1	1.3	pF
$V_{\text{CB}}$ = 10 V, $V_{\text{BE}}$ = vbe = 0, f = 1 MHz					
Collector-emitter capacitance	C <sub>CE</sub>	-	0.44	-	pF
$V_{\text{CE}}$ = 10 V, $V_{\text{BE}}$ = vbe = 0, f = 1 MHz					
Emitter-base capacitance	C <sub>EB</sub>	-	3,6	4,3	pF
$V_{\text{EB}}=0.5V,V_{\text{CB}}=vcb=0,f=1MHz$					
Noise Figure	F	-	3	3.5	dB
$I_{C}$ = 20 mA, $V_{CE}$ = 5 V, f = 2 GHz,					
$Z_{\rm S} = Z_{\rm Sopt}$					
Power gain	Gma <sup>1.)</sup>	10	11	-	dB
$I_{C}$ = 70 mA, $V_{CE}$ = 5V, f = 2 GHz					
$Z_{S} = Z_{Sopt}$ , $Z_{L} = Z_{Lopt}$					
Transducer gain	$ S_{21e} ^2$	4	5	-	dB
$I_{C}$ = 70 mA, $V_{CE}$ = 5 V, f = 2 GHz					
$Z_{S} = Z_{L} = 50 \ \Omega$					
Output Power	P <sub>OUT</sub>	18.5	19.5	-	dBm
$I_{C}$ = 80 mA, $V_{CE}$ = 5 V, f = 2 GHz ,					
$P_{IN}$ =15 dBm, $Z_S$ = $Z_L$ = 50 $\Omega$					

### Notes .:

1) 
$$G_{ma} = \left| \frac{S21}{S12} \right| (k - \sqrt{k^2 - 1}), \quad G_{ms} = \left| \frac{S21}{S12} \right|$$



# Micro-X1 Package



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